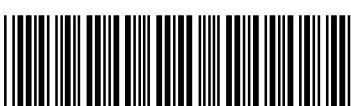


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10603099	ZABAWSKYJ ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Thier, Michael T	2617

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	updated	8/17/2010	/mtt/

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
updated	8/17/2010	/mtt/

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	see attached EAST interference search.	8/17/2010	/mtt/

--	--